

TOSHIBA POWER MOS FET MODULE SILICON N & P CHANNEL MOS TYPE (L<sup>2</sup>-π-MOSIV 6 IN 1)

# MP6801

HIGH POWER, HIGH SPEED SWITCHING APPLICATIONS.

3-PHASE MOTOR DRIVE AND BIPOLAR DRIVE OF PULSE MOTOR.

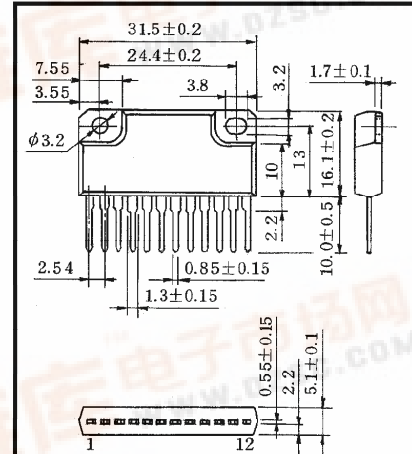
- 4-Volt Gate Drive.
- Package with Heat Sink Isolated to Lead. (SIP 12Pin)
- High Drain Power Dissipation.  
: P<sub>T</sub>=40W @T<sub>c</sub>=25°C (6 Device Operation)
- Low Drain-Source ON Resistance  
: R<sub>DS(ON)</sub>=55mΩ (Typ.) (N-ch)  
90mΩ (Typ.) (P-ch)
- Low Leakage Current : I<sub>GSS</sub>=±10μA (Max.) @V<sub>DS</sub>=±16V  
: I<sub>DSS</sub>=100μA (Max.) @V<sub>DS</sub>=60V
- Enhancement-Mode : V<sub>th</sub>=0.8~2.0V @I<sub>D</sub>=1mA

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING		UNIT
		N-ch	P-ch	
Drain-Source Voltage	V <sub>DSS</sub>	60	-60	V
Gate-Source Voltage	V <sub>GSS</sub>	±20	±20	V
Drain Current	I <sub>D</sub>	10	-10	A
Peak Drain Current	I <sub>DP</sub>	30	-30	
Drain Power Dissipation (1 Device Operation, Ta = 25°C)	P <sub>D</sub>	3.0		W
Drain Power Dissipation (6 Devices Operation)	P <sub>T</sub>	5.0		W
		40		
Channel Temperature	T <sub>ch</sub>	150		°C
Storage Temperature Range	T <sub>stg</sub>	-55~150		°C

INDUSTRIAL APPLICATIONS

Unit in mm

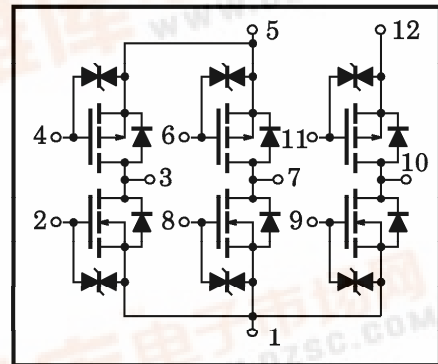


2, 4, 6, 8, 9, 11 Gate  
3, 7, 10 Drain  
1, 5, 12 Source

JEDEC	—
EIAJ	—
TOSHIBA	2-32B3A

Weight : 6g

ARRAY CONFIGURATION



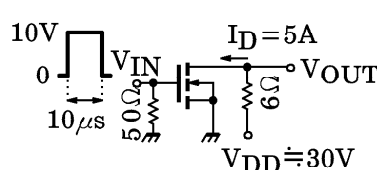
THERMAL CHARACTERISTICS

CHARACTERISTIC	SYMBOL	MAX.	UNIT
Thermal Resistance of Junction to Ambient (6 Devices Operation, Ta = 25°C)	ΣR <sub>th(j-a)</sub>	25	°C / W
Thermal Resistance of Junction to Case (6 Devices Operation, Tc = 25°C)	ΣR <sub>th(j-c)</sub>	3.12	°C / W
Maximum Lead Temperature for Soldering Purposes (3.2mm from Case for 10s)	T <sub>L</sub>	260	°C

This transistor is an electrostatic sensitive device. Please handle with caution.



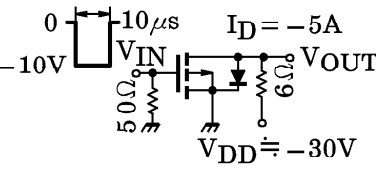
ELECTRICAL CHARACTERISTICS (Ta = 25°C) (N-ch MOS FET)

CHARACTERISTIC		SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Gate Leakage Current		$I_{GSS}$	$V_{GS} = \pm 16V, V_{DS} = 0$	—	—	$\pm 10$	$\mu A$
Drain Cut-off Current		$I_{DSS}$	$V_{DS} = 60V, V_{GS} = 0$	—	—	100	$\mu A$
Drain-Source Breakdown Voltage		$V_{(BR)DSS}$	$I_D = 10mA, V_{GS} = 0$	60	—	—	V
Gate Threshold Voltage		$V_{th}$	$V_{DS} = 10V, I_D = 1mA$	0.8	—	2.0	V
Forward Transfer Admittance		$ Y_{fs} $	$V_{DS} = 10V, I_D = 5A$	5	11	—	S
Drain-Source ON Resistance		$R_{DS(ON)}$	$I_D = 5A, V_{GS} = 4V$	—	80	115	m $\Omega$
Drain-Source ON Resistance		$R_{DS(ON)}$	$I_D = 5A, V_{GS} = 10V$	—	55	80	
Input Capacitance		$C_{iss}$	$V_{DS} = 10V, V_{GS} = 0, f = 1MHz$	—	750	—	pF
Reverse Transfer Capacitance		$C_{rss}$		—	170	—	
Output Capacitance		$C_{oss}$		—	450	—	
Switching Time	Rise Time	$t_r$	 <p><math>I_D = 5A</math> <math>V_{DD} = 30V</math></p>	—	60	—	ns
	Turn-on Time	$t_{on}$		—	80	—	
	Fall Time	$t_f$		—	150	—	
	Turn-off Time	$t_{off}$		$V_{IN} : t_r, t_f < 5ns$ $Du. \leq 1\% (Z_{OUT} = 50\Omega)$	—	400	
Total Gate Charge (Gate-Source Plus Gate-Drain)		$Q_g$	$I_D = 10A, V_{GS} = 10V$ $V_{DD} = 48V$	—	30	—	nC
Gate-Source Charge		$Q_{gs}$		—	20	—	
Gate-Drain (“Miller”) Charge		$Q_{gd}$		—	10	—	

SOURCE-DRAIN DIODE RATING AND CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Drain Reverse Current	$I_{DR}$	—	—	—	-10	A
Peak Drain Reverse Current	$I_{DRP}$	—	—	—	-30	A
Diode Forward Voltage	$V_{DSF}$	$I_{DR} = 10A, V_{GS} = 0$	—	-1.0	-1.7	V
Reverse Recovery Time	$t_{rr}$	$I_{DR} = 10A, V_{GS} = 0$	—	110	—	ns
Reverse Recovery Charge	$Q_{rr}$	$dI_{DR} / dt = -50A / \mu s$	—	0.27	—	$\mu C$

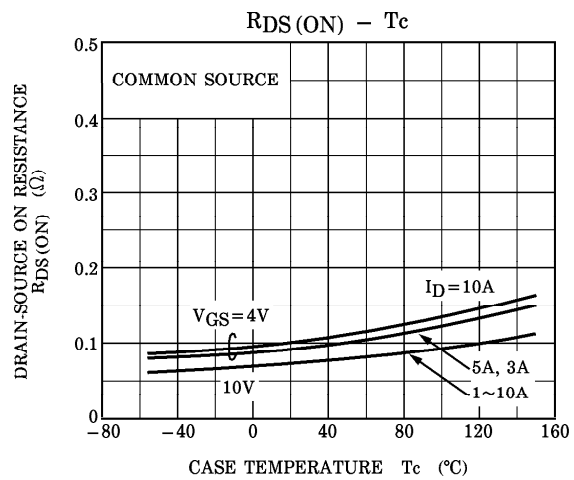
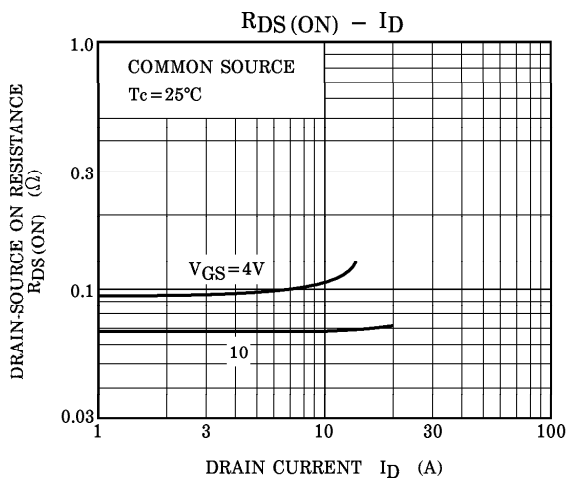
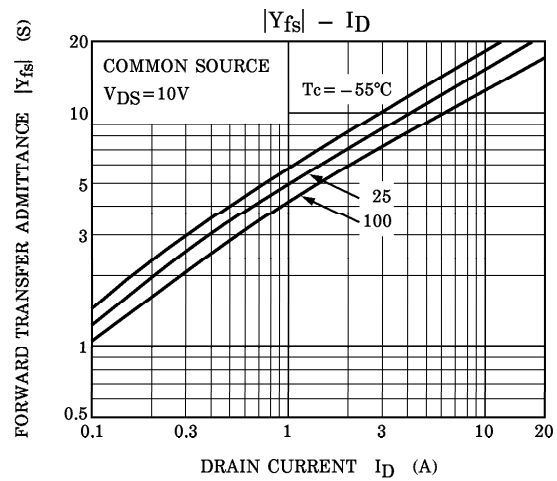
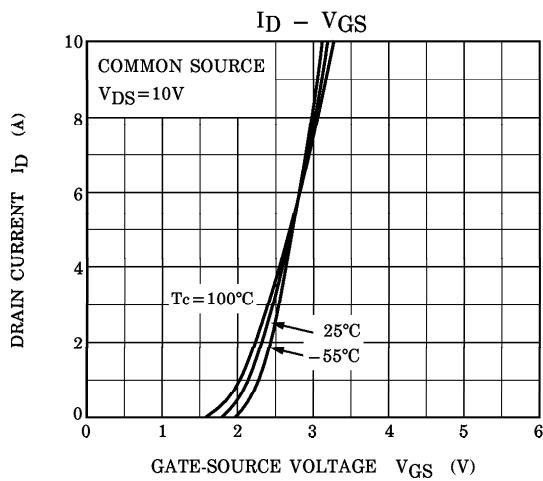
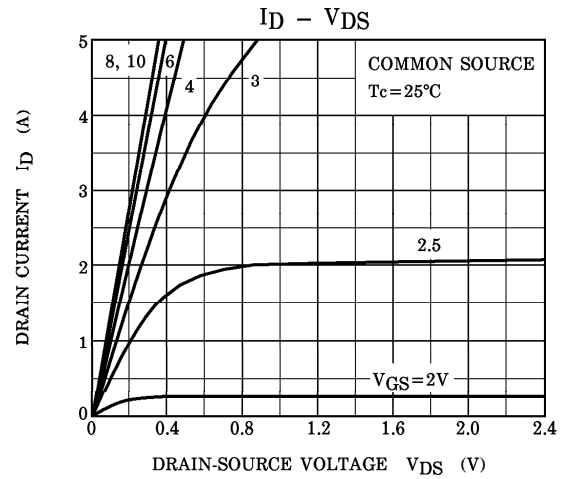
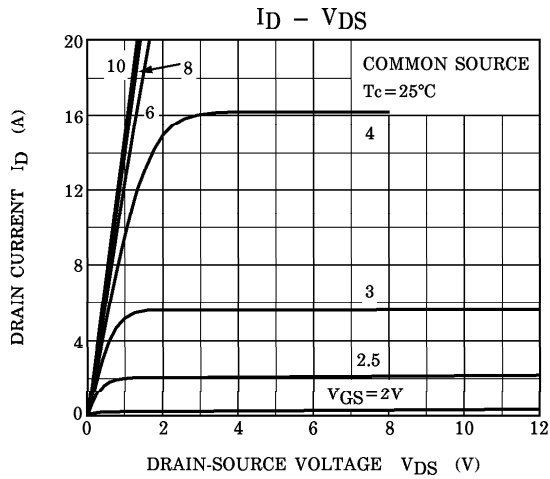
ELECTRICAL CHARACTERISTICS (Ta = 25°C) (P-ch MOS FET)

CHARACTERISTIC		SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Gate Leakage Current		$I_{GSS}$	$V_{GS} = \pm 16V, V_{DS} = 0$	—	—	$\pm 10$	$\mu A$
Drain Cut-off Current		$I_{DSS}$	$V_{DS} = -60V, V_{GS} = 0$	—	—	-100	$\mu A$
Drain-Source Breakdown Voltage		$V_{(BR)DSS}$	$I_D = -10mA, V_{GS} = 0$	-60	—	—	V
Gate Threshold Voltage		$V_{th}$	$V_{DS} = -10V, I_D = -1mA$	-0.8	—	-2.0	V
Forward Transfer Admittance		$ Y_{fs} $	$V_{DS} = -10V, I_D = -5A$	3.5	8.0	—	S
Drain-Source ON Resistance		$R_{DS(ON)}$	$I_D = -5A, V_{GS} = -4V$	—	145	200	m $\Omega$
Drain-Source ON Resistance		$R_{DS(ON)}$	$I_D = -5A, V_{GS} = -10V$	—	90	125	
Input Capacitance		$C_{iss}$	$V_{DS} = -10V, V_{GS} = 0,$ $f = 1MHz$	—	1200	—	pF
Reverse Transfer Capacitance		$C_{rss}$		—	220	—	
Output Capacitance		$C_{oss}$		—	550	—	
Switching Time	Rise Time	$t_r$		—	60	—	ns
	Turn-on Time	$t_{on}$		—	80	—	
	Fall Time	$t_f$		—	120	—	
	Turn-off Time	$t_{off}$		$V_{IN} : t_r, t_f < 5ns$ $Du. \leq 1\% (Z_{OUT} = 50\Omega)$	—	350	
Total Gate Charge (Gate-Source Plus Gate-Drain)		$Q_g$	$I_D = -10A, V_{GS} = -10V$ $V_{DD} = -48V$	—	45	—	nC
Gate-Source Charge		$Q_{gs}$		—	30	—	
Gate-Drain ("Miller") Charge		$Q_{gd}$		—	15	—	

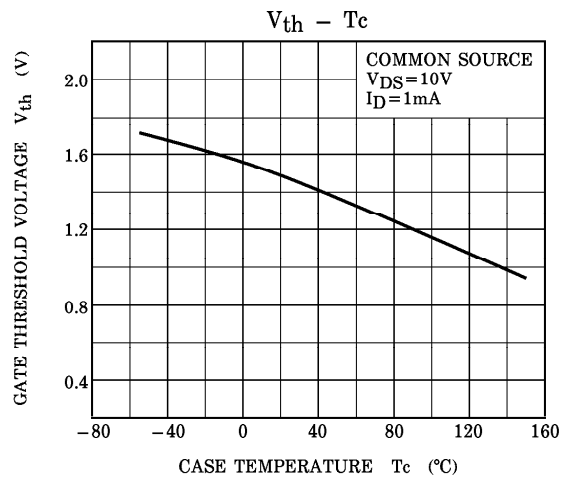
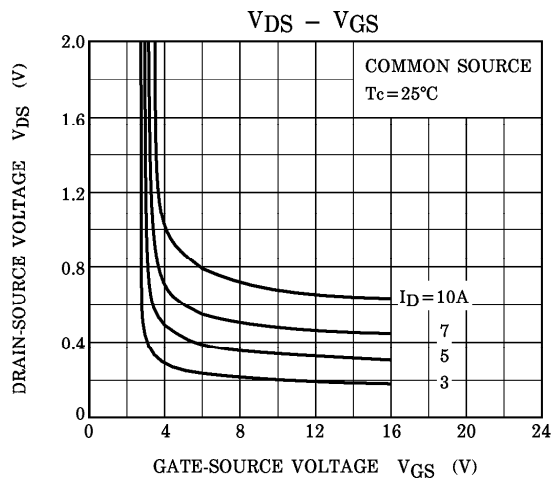
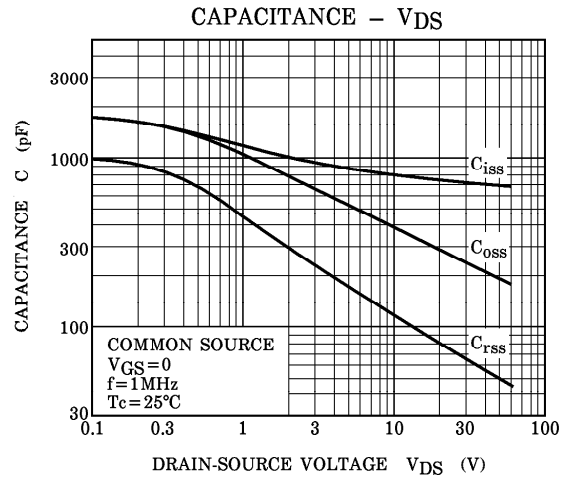
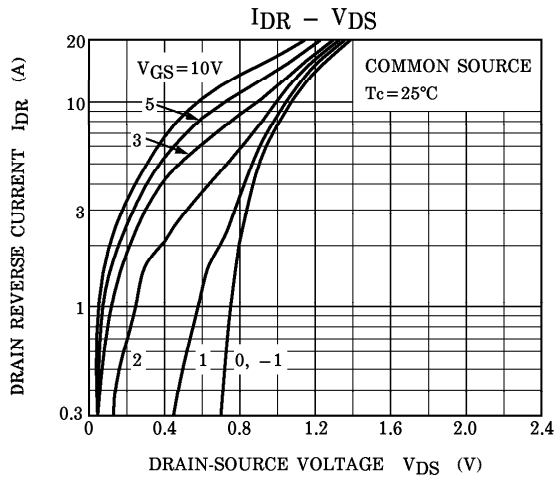
SOURCE-DRAIN DIODE RATING AND CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Drain Reverse Current	$I_{DR}$	—	—	—	-10	A
Peak Drain Reverse Current	$I_{DRP}$	—	—	—	-30	A
Diode Forward Voltage	$V_{DSF}$	$I_{DR} = -10A, V_{GS} = 0$	—	-0.9	-1.7	V
Reverse Recovery Time	$t_{rr}$	$I_{DR} = -10A, V_{GS} = 0$	—	110	—	ns
Reverse Recovery Charge	$Q_{rr}$	$dI_{DR} / dt = 50A / \mu s$	—	0.18	—	$\mu C$

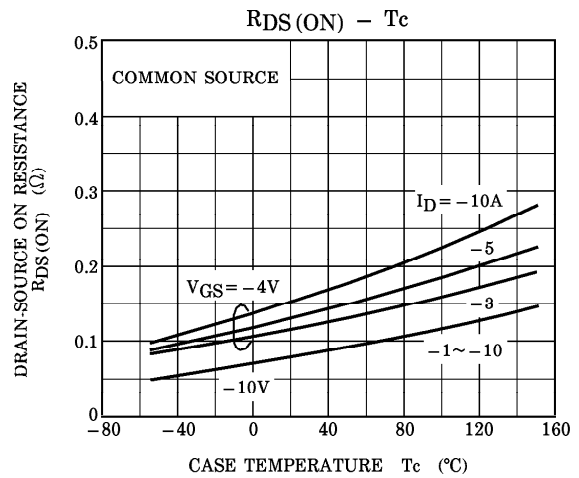
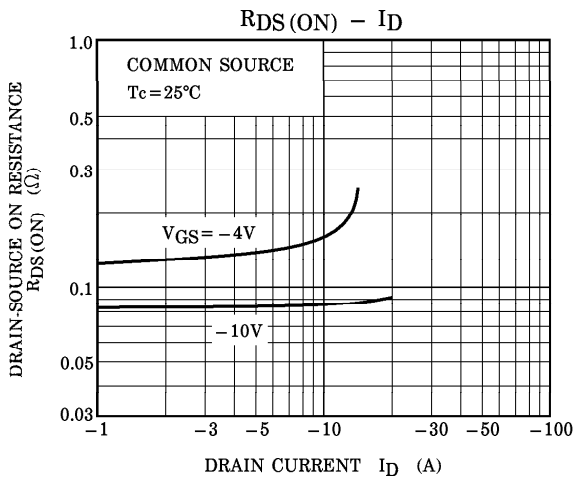
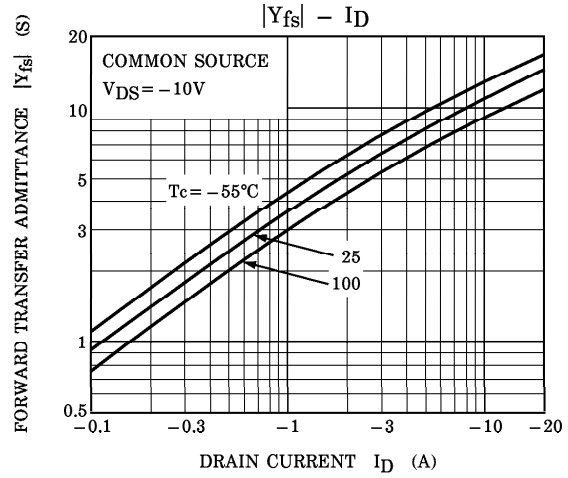
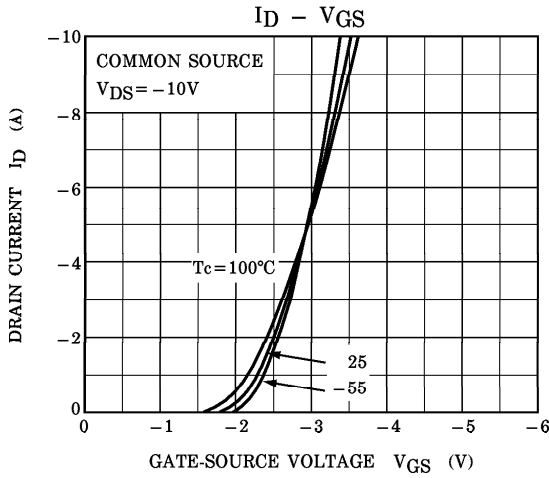
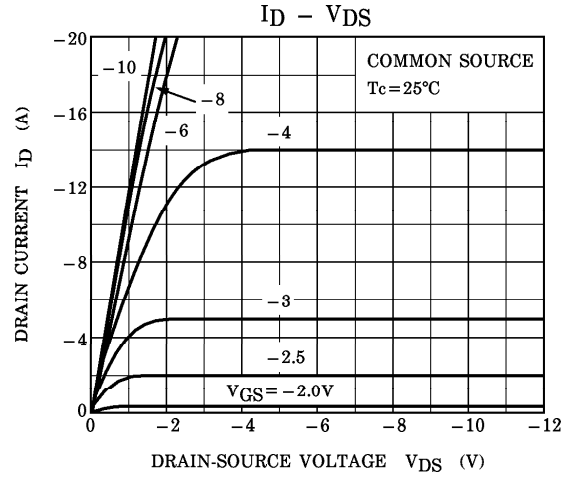
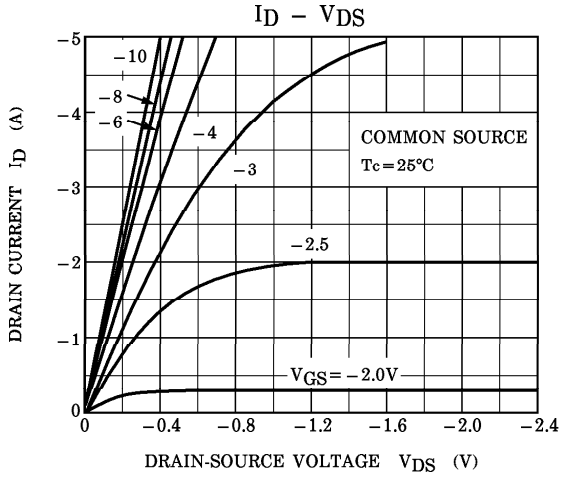
N-ch



N-ch



P-ch



P-ch

